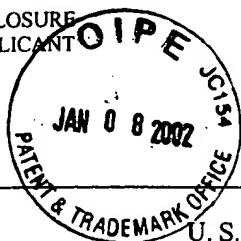


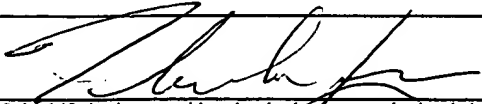
FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY DOCKET NO. 18079-300101	SERIAL NO. 09/858,350
	APPLICANT JHE et al.	
	FILING DATE May 15, 2001	GROUP 288+ 2878



U. S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TXL	AA	4,851,671	07/25/89	Pohl	250	306	03/07/88
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	APPLICANT JHE et al.	
	FILING DATE May 15, 2001	GROUP 2878 <del>Not yet assigned</del>

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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### FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUBCLASS	TRANSLATION YES NO
	AH							

### OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AI	Yongho Seo, June H. Park, Kin B. Moon, and Wonho Jhe, "Fast-scanning shear-force microscopy using a high-frequency dithering probe" <i>Applied Physics Letters</i> , Vol. 77, No. 26, 25 December 2000.
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EXAMINER 	DATE CONSIDERED 8/02
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	